

# Philip Nakashima

## List of Publications by Year in descending order

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31  
papers

602  
citations

687363

13  
h-index

610901

24  
g-index

33  
all docs

33  
docs citations

33  
times ranked

671  
citing authors

#	ARTICLE	IF	CITATIONS
1	Growth of faceted, monolayer-coated nanovoids in aluminium. <i>Acta Materialia</i> , 2021, 206, 116594.	7.9	2
2	Measuring Density Functional Parameters from Electron Diffraction Patterns. <i>Physical Review Letters</i> , 2021, 126, 176402.	7.8	2
3	Characterisation of Li in the surface film of a corrosion resistant Mg-Li(-Al-Y-Zr) alloy. <i>Applied Surface Science</i> , 2019, 494, 1066-1071.	6.1	36
4	Identification of the impurity phase in high-purity CeB <sub>6</sub> by convergent-beam electron diffraction. <i>Acta Crystallographica Section A: Foundations and Advances</i> , 2019, 75, 489-500.	0.1	1
5	Quantum Crystallography: Current Developments and Future Perspectives. <i>Chemistry - A European Journal</i> , 2018, 24, 10881-10905.	3.3	108
6	Three-beam convergent-beam electron diffraction for measuring crystallographic phases. <i>IUCr</i> , 2018, 5, 753-764.	2.2	5
7	Topologically Enclosed Aluminum Voids as Plasmonic Nanostructures. <i>ACS Nano</i> , 2017, 11, 11383-11392.	14.6	15
8	Quantitative convergent-beam electron diffraction and quantum crystallography – the metallic bond in aluminium. <i>Structural Chemistry</i> , 2017, 28, 1319-1332.	2.0	11
9	How do specimen preparation and crystal perfection affect structure factor measurements by quantitative convergent-beam electron diffraction?. <i>Journal of Applied Crystallography</i> , 2017, 50, 602-611.	4.5	8
10	Mechanisms of void shrinkage in aluminium. <i>Journal of Applied Crystallography</i> , 2016, 49, 1459-1470.	4.5	13
11	Conjugated precipitation of twin-related $\hat{\Gamma}_2$ and Ti <sub>2</sub> Cu phases in a Ti-25V-3Cu alloy. <i>Acta Materialia</i> , 2015, 84, 457-471.	7.9	32
12	Frontiers of Electron Microscopy in Materials Science. <i>Microscopy and Microanalysis</i> , 2014, 20, 999-1000.	0.4	0
13	Direct atomic structure determination by the inspection of structural phase. <i>Proceedings of the National Academy of Sciences of the United States of America</i> , 2013, 110, 14144-14149.	7.1	5
14	In situ quantification of noise as a function of signal in digital images. <i>Optics Letters</i> , 2012, 37, 1023.	3.3	5
15	Aberration-corrected scanning transmission electron microscopy study of $\hat{\Gamma}_2$ -like precipitates in an Al-Mg-Ge alloy. <i>Acta Materialia</i> , 2012, 60, 3239-3246.	7.9	24
16	Projected thickness reconstruction from a single defocused transmission electron microscope image of an amorphous object. <i>Ultramicroscopy</i> , 2011, 111, 959-968.	1.9	10
17	Precipitates in an Al-Mg-Ge alloy studied by aberration-corrected scanning transmission electron microscopy. <i>Acta Materialia</i> , 2011, 59, 6103-6109.	7.9	17
18	A new approach to structure amplitude determination from 3-beam convergent beam electron diffraction patterns. <i>Ultramicroscopy</i> , 2011, 111, 841-846.	1.9	3

#	ARTICLE	IF	CITATIONS
19	The Bonding Electron Density in Aluminum. <i>Science</i> , 2011, 331, 1583-1586.	12.6	141
20	Optimization of exit-plane waves restored from HRTEM through-focal series. <i>Ultramicroscopy</i> , 2010, 110, 151-161.	1.9	15
21	Differential quantitative analysis of background structure in energy-filtered convergent-beam electron diffraction patterns. <i>Journal of Applied Crystallography</i> , 2010, 43, 280-284.	4.5	7
22	Mesoporous carbon confined conversion of silica nanoparticles into zeolite nanocrystals. <i>Microporous and Mesoporous Materials</i> , 2009, 117, 490-496.	4.4	12
23	A practical guide to the measurement of structure phases and magnitudes by three-beam convergent beam electron diffraction. <i>Ultramicroscopy</i> , 2008, 108, 901-910.	1.9	5
24	Thickness Difference: A New Filtering Tool for Quantitative Electron Diffraction. <i>Physical Review Letters</i> , 2007, 99, 125506.	7.8	16
25	Novel CBED Methods for Structure Analysis. <i>Microscopy and Microanalysis</i> , 2006, 12, 792-793.	0.4	0
26	Crystal structure study of a $\hat{\Gamma}^2\hat{a}^2$ -copper vanadium bronze, $\text{Cu}_x\text{V}_2\text{O}_5$ ( $x = 0.63$ ), by X-ray and convergent beam electron diffraction. <i>Acta Crystallographica Section B: Structural Science</i> , 2005, 61, 17-24.	1.8	10
27	Improved quantitative CBED structure-factor measurement by refinement of nonlinear geometric distortion corrections. <i>Journal of Applied Crystallography</i> , 2005, 38, 374-376.	4.5	11
28	Measuring the PSF from aperture images of arbitrary shape—an algorithm. <i>Ultramicroscopy</i> , 2003, 94, 135-148.	1.9	26
29	A Combination Method of Charge Density Measurement in Hard Materials Using Accurate, Quantitative Electron and X-ray Diffraction: The $\hat{\Gamma}^2\hat{a}^2$ - $\text{Al}_2\text{O}_3$ Case. <i>Microscopy and Microanalysis</i> , 2003, 9, 419-427.	0.4	17
30	Charge density analysis from complementary high energy synchrotron X-ray and electron diffraction data. <i>Journal of Physics and Chemistry of Solids</i> , 2001, 62, 2109-2117.	4.0	23
31	Particle size dependence of the volume plasmon energy in cadmium sulphide quantum dots by electron energy loss spectroscopy. <i>Journal of Applied Physics</i> , 1999, 85, 1556-1559.	2.5	22